

Application/Control No.	Applicant(s)/Patent under Reexamination
10/511,632	IKEDA ET AL.
Examiner	Art Unit
Bethany P. Barham	1615

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East (See attached search notes)	11/21/2007	ВВ	
STIC structure search	11/21/2007	ВВ	
Palm Inventors Search	11/21/2007	BB	
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